

## The University of Michigan Radiation Laboratory 3228 EECS Building

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Measured Radio Frequency Emissions From

Lear Corporation Transmitter FCC ID: KOBJTF10A IC: 3521A-JTF10A

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For:

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## **Summary**

Tests for compliance with FCC Regulations, CFR 47, Part 15 and with Industry Canada RSS-210/Gen, were performed on a Lear, FCC ID: KOBJTF10A, IC: 3521A-JTF10A. This device under test (DUT) is subject to the rules and regulations as a Transmitter.

In testing completed on January 11, 2009, the DUT tested met the allowed specifications for radiated emissions by 0.2 dB. Conducted emissions are not subject to regulation as the DUT is powered by a 3VDC battery.

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#### 1. Introduction

This Lear Transmitter was tested for compliance with FCC Regulations, Part 15, adopted under Docket 87-389, April 18, 1989 as subsequently amended, and with Industry Canada RSS-210/Gen, Issue 7, June 2007. Tests were performed at the University of Michigan Radiation Laboratory Willow Run Test Range following the procedures described in ANSI C63.4-2003 "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz". The Site description and attenuation characteristics of the Open Site facility are on file with FCC Laboratory, Columbia, Maryland (FCC Reg. No: 91050) and with Industry Canada, Ottawa, ON (File Ref. No: IC 2057A-1).

## 2. Equipment Used

The test equipment commonly used in our facility is listed in Table 2.1. Except where indicated as a pretest, monitoring, or support device; all equipment listed below is a part of the University of Michigan Radiation Laboratory (UMRL) quality system. This quality system has been established to ensure all equipment has a clearly identifiable classification, calibration expiry date, and that all calibrations are traceable to national standards.

Table 2.1 Test Equipment.

<b>Test Instrument</b>	Used	Manufacturer/Model	Q Number
Spectrum Analyzer (9kHz-26GHz)	$\boxtimes$	Hewlett-Packard 8593E, SN: 3412A01131	HP8593E1
Spectrum Analyzer (9kHz-6.5GHz)	$\boxtimes$	Hewlett-Packard 8595E, SN: 3543A01546	JDB8595E
Power Meter		Hewlett-Packard, 432A	HP432A1
Harmonic Mixer (26-40 GHz)		Hewlett-Packard 11970A, SN: 3003A08327	HP11970A1
Harmonic Mixer (40-60 GHz)		Hewlett-Packard 11970U, SN: 2332A00500	HP11970U1
Harmonic Mixer (75-110 GHz)		Hewlett-Packard 11970W, SN: 2521A00179	HP11970W1
Harmonic Mixer (140-220 GHz)		Pacific Millimeter Prod., GMA, SN: 26	PMPGMA1
S-Band Std. Gain Horn		S/A, Model SGH-2.6	SBAND1
C-Band Std. Gain Horn		University of Michigan, NRL design	CBAND1
XN-Band Std. Gain Horn		University of Michigan, NRL design	XNBAND1
X-Band Std. Gain Horn		S/A, Model 12-8.2	XBAND1
X-band horn (8.2- 12.4 GHz)		Narda 640	XBAND2
X-band horn (8.2- 12.4 GHz)		Scientific Atlanta, 12-8.2, SN: 730	XBAND3
K-band horn (18-26.5 GHz)		FXR, Inc., K638KF	KBAND1
Ka-band horn (26.5-40 GHz)		FXR, Inc., U638A	KABAND1
U-band horn (40-60 GHz)		Custom Microwave, HO19	UBAND1
W-band horn(75-110 GHz)		Custom Microwave, HO10	WBAND1
G-band horn (140-220 GHz)		Custom Microwave, HO5R	GBAND1
Bicone Antenna (30-250 MHz)	$\boxtimes$	University of Michigan, RLBC-1	LBBIC1
Bicone Antenna (200-1000 MHz)	$\boxtimes$	University of Michigan, RLBC-2	HBBIC1
Dipole Antenna Set (30-1000 MHz)	$\boxtimes$	University of Michigan, RLDP-1,-2,-3	UMDIP1
Dipole Antenna Set (30-1000 MHz)		EMCO 3121C, SN: 992 (Ref. Antennas)	EMDIP1
Active Rod Antenna (30 Hz-50 MHz)		EMCO 3301B, SN: 3223	EMROD1
Active Loop Antenna (30 Hz-50 MHz)		EMCO 6502, SN:2855	EMLOOP1
Ridge-horn Antenna (300-5000 MHz)	$\boxtimes$	University of Michigan	UMRH1
Amplifier (5-1000 MHz)		Avantek, A11-1, A25-1S	AVAMP1
Amplifier (5-4500 MHz)	$\boxtimes$	Avantek	AVAMP2
Amplifier (4.5-13 GHz)		Avantek, AFT-12665	AVAMP3
Amplifier (6-16 GHz)		Trek	TRAMP1
Amplifier (16-26 GHz)		Avantek	AVAMP4
LISN Box		University of Michigan	UMLISN1
Signal Generator		Hewlett-Packard 8657B	HPSG1

#### 3. Device Under Test

## 3.1 Description & Block Diagram

The DUT is a 315 MHz keyfob transmitter designed for automotive/vehicular applications. It is powered by a 3VDC lithium battery and is housed in a plastic case approximately 7 x 5 x 1.5 cm in dimension. The DUT is designed and manufactured by Lear Corporation, 21557 Telegraph Rd, Southfield, MI 48033.

## 3.2 Variants and Samples

There are a total of two variants for this device. Both variants employ identical circuits and PCBs, but have minor changes to exterior labeling and metal engraving. Four samples were provided for testing. Samples DUT1 and DUT2 (below) have the have Range Rover housing and are normal operating and CW modified devices, samples DUT3 and DUT4 have Land Rover housings and are normal and CW modified.

Device	[Make], Model	[S/N],P/N	<b>EMC Consideration</b>
DUT1	[Lear], Range Rover	[NA01], 5E0B50227	Normal Mode Device
DUT2	[Lear], Range Rover	[NA02], 5E0B50227	CW Modified
DUT3	[Lear], Land Rover	[NA03], 5E0B60227	CW Modified
DUT4	[Lear], Land Rover	[NA04], 5E0B60227	Normal Mode Device

On these devices the end-user is able to open metal drawers on either side of the product to replace the battery or fold-out the backup metal key. To ensure RF emissions compliance in all drawer configurations, the devices here are tested for worst case emissions with (1) both drawers shut and (2) both drawers open with the key fully extended. Minimal change in emissions is reported.

## 3.3 Modes of Operation

The DUT is capable of two modes of activation.

The primary mode of activation is via button press, which results in the lowest duty factor (worst case) transmission. This transmission consists of interwoven ASK and FSK words that continually step through three frequencies centered at 314.682 MHz, 315.000 MHz, and 315.318 MHz. Since all three frequencies are used sequentially, bandwidth is demonstrated to comply in a cumulative fashion.

The secondary mode of activation is by encoded, manually initiated, LF interrogation. This mode responds employing only a single high duty (low average) ASK response consisting of only a single transmitted word.

Both modes are documented herein, and the peak power setting for the DUT does not change for the different modes of operation.

## 3.4 Exemptions

None.

#### 3.5 EMC Relevant Modifications

No EMI Relevant Modifications were performed by this test laboratory.

#### 4. Emissions Limits

#### 4.1 Radiated Emissions Limits

The DUT tested falls under the category of an Intentional Radiator. The applicable testing frequencies and corresponding emission limits set by both the FCC and IC are given in Tables 4.1 and 4.2 below.

Table 4.1. TX Emission Limits (FCC: 15.231(b), .205(a); IC: RSS-210 2.7 T4).

Frequency	Fundaı Ave. E <sub>l</sub>		Spurious** Ave. E <sub>lim</sub> (3m)		
(MHz)	$(\mu V/m)$	$dB \; (\mu V/m)$	$(\mu V/m)$	dB (μV/m)	
260.0-470.0	3750-12500*		375-1250		
315	6042	75.6	604.2	55.6	
433.9	10966	80.8	1096.6	60.8	
322-335.4 399.9-410 608-614	Restr Bar		200	46.0	
960-1240/1427(IC) 1300-1427 1435-1626.5 1645.5-1646.5 (IC) 1660-1710 1718.9-1722.2 2200-2300	Restr Bar		500	54.0	

<sup>\*</sup> Linear interpolation, formula: E = -7083 + 41.67\*f (MHz)

Table 4.2. Spurious Emission Limits (FCC: 15.33, .35, .109/209; IC: RSS-210 2.7, T2)

Freq. (MHz)	$E_{lim}$ (3m) $\mu$ V/m	$E_{lim} dB(\mu V/m)$
30-88	100	40.0
88-216	150	43.5
216-960	200	46.0
960-2000	500	54.0

Note: Average readings apply above 1000 MHz (1 MHz BW), Quasi-Peak readings apply to 1000 MHz (120 kHz RBW), PRF of intentional emissions > 20 Hz for QPK to apply.

#### 4.2 Power Line Conducted Emissions Limits

Table 4.3 Emission Limits (FCC:15.107 (CISPR); IC: RSS-Gen, 7.2.2 T2).

Frequency	Class A	$(dB\mu V)$	Class B (dBµV)			
(MHz)	Quasi-peak	Average	Quasi-peak	Average		
.150 - 0.50	79	66	66 - 56*	56 - 46*		
0.50 - 5	73	60	56	46		
5 - 30	73	60	60	50		

#### Notes:

- 1. The lower limit shall apply at the transition frequency
- 2. The limit decreases linearly with the logarithm of the frequency in the range 0.15-0.50 MHz:
  - \*Class B Quasi-peak:  $dB\mu V = 50.25 19.12*log(f)$
  - \*Class B Average:  $dB\mu V = 40.25 19.12*log(f)$
- 3. 9 kHz RBW

<sup>\*\*</sup> Measure up to tenth harmonic; 120 kHz BW up to 1 GHz, 1 MHz BW above 1 GHz

#### 5. Measurement Procedures

#### 5.1 Semi-Anechoic Chamber Radiated Emissions

To become familiar with the radiated emission behavior of the DUT, the device is first studied and measured in our shielded semi-anechoic chamber. In the chamber there is a set-up similar to that of an outdoor 3-meter site, with a turntable, an antenna mast, and a ground plane. Instrumentation includes spectrum analyzers and other equipment as needed.

The DUT is laid on the test table as shown in the included block diagram. A shielded loop antenna is employed when studying emissions from 9 kHz to 30 MHz. Above 30 MHz and below 250 MHz a biconical antenna is employed. Above 250 MHz a ridge or and standard gain horn antennas are used. The spectrum analyzer resolution and video bandwidths are set so as to measure the DUT emission without decreasing the emission bandwidth (EBW) of the device. Emissions are studied for all orientations (3-axes) of the DUT and all test antenna polarizations. In the chamber spectrum and modulation characteristics of the carrier are recorded. This data is presented in subsequent sections.

#### **5.2 Outdoor Radiated Emissions**

After measurements are performed indoors, emissions on our outdoor 3-meter Open Area Test Site (OATS) are made. If the DUT connects to auxiliary equipment and is table or floor standing, the configurations prescribed in ANSI C63.4 are employed. Alternatively, an on-table layout more representative of actual use may be employed if the resulting emissions appear to be worst-case in such a configuration. Any intentionally radiating elements are placed on the test table flat, on their side, and on their end (3-axes) and worst case emissions are recorded. For devices with intentional emissions below 30 MHz, our shielded loop antenna is used and low frequency field extrapolation to the regulatory limit distance is employed as needed. Emissions between 30 MHz and 1 GHz are measured using tuned dipoles and/or biconical antennas. Care is taken to ensure that the RBW and VBW used meet the regulatory requirements, and that the EBW of the DUT is not reduced. The Photographs included in this report show the DUT on the OATS.

## **5.3 Radiated Field Computations**

To convert the dBm values measured on the spectrum analyzer to  $dB(\mu V/m)$ , we use expression

 $E3(dB\mu V/m) = 107 + PR + KA - KG + KE - CF$ 

where PR = power recorded on spectrum analyzer, dB, measured at 3 m

KA = antenna factor, dB/m

KG = pre-amplifier gain, including cable loss, dB

KE = duty correction factor, dB

CF = distance conversion (employed only if limits are specified at alternate distance), dB

When presenting the data at each frequency, the highest measured emission under all of the possible DUT orientations (3-axes) is given.

## **5.4** Indoor Power Line Conducted Emissions

When applicable, power line conducted emissions are measured in our semi-anechoic chamber. If the DUT connects to auxiliary equipment and is table or floor standing, the configurations prescribed in ANSI C63.4 are employed. Alternatively, an on-table layout more representative of actual use may be employed if the resulting emissions appear to be worst-case in such a configuration.

The conducted emissions measured with the spectrum analyzer and recorded (in  $dB\mu V$ ) from 0-2 MHz and 2-30 MHz for both the ungrounded (Hi) and grounded (Lo) conductors. The spectrum analyzer is set to peak-hold mode in order to record the highest peak throughout the course of functional operation. Only when the emission exceeds or is near the limit are quasi-peak and average detection used.

## 5.5 Supply Voltage Variation

Measurements of the variation in the fundamental radiated emission were performed with the supply voltage varied by no less than 85% and 115% of the nominal rated value. For battery operated equipment, tests were performed using a new battery, and worst case emissions are re-checked employing a new battery.

#### 6. Test Results

#### **6.1 Radiated Emissions**

#### **6.1.1** Correction for Pulse Operation

When the transmitter is activated by button press it transmits, in the worst case, 50.625 ms of Manchester encoded ASK data within any given 100 ms window, and 21.825 ms of FSK in any other 100 ms window. When interrogated by a manually activated LF signal the DUT transmits only a single 2.5 ms Manchester encoded ASK word. See Figure 6.1. Computing the duty factor results in:

$$\begin{split} K_{E(Button\;ASK)} &= (129.6\;us/\;255.6\;us)\;x\;(50.625\;ms\:/\:100\;ms) = 0.257\;or\;\textbf{-11.8}\;\textbf{dB.} \\ K_{E(Button\;FSK)} &= 21.825\;ms\:/\:100\;ms = 0.218\;or\;\textbf{-13.2}\;dB. \\ K_{E(LF\;ASK)} &= (26.6\;us/\;49.4\;us)\;x\;(2.5\;ms\:/\:100\;ms) = 0.013 < \textbf{-20.0}\;dB. \end{split}$$

The worst case duty cycle of -11.8 dB is thus applied to all CW measurements made.

## **6.1.2 Emission Spectrum**

The relative DUT emission spectrum is recorded and is shown in Figure 6.2.

#### **6.1.3** Emission Bandwidth

The emission bandwidth of the signal (in both button press and LF activated modes) is shown in Figure 6.3. The allowed 99% bandwidth is 0.25% of 315 MHz, or 787.25 kHz. From the plot we see that the worst case cumulative EBW is 739.0 kHz and the center frequency is 315 MHz.

#### **6.1.4** Supply Voltage and Supply Voltage Variation

The DUT has been designed to be powered by a 3VDC battery. For this test, relative radiated power was measured at the fundamental as the voltage was varied from 2.0 to 3.5 volts. The emission variation is shown in Figure 6.4.

Batteries: before testing  $V_{oc} = 3.29 \text{ V}$  $V_{oc} = 2.99 \text{ V}$ after testing

I = 5.1 mA (cw)Ave. current from batteries

#### **6.2 Conducted Emissions**

These tests do not apply, since the DUT is powered from a 3VDC battery.

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**Table 5.1 Highest Emissions Measured** 

	Radiated Emission - RF								Lear, LR/RR FOB; FCC/IC		
	Freq.	Ant.	Ant.	Pr	Det.	Ka	Kg	E3*	E3lim	Pass	
#	MHz	Used	Pol.	dBm	Used	dB/m	dB	dBμV/m	dBμV/m	dB	Comments
1											
2	315.0	Dip	Н	-16.9	Pk	18.6	21.5	75.4	75.6	0.2	flat
3	315.0	Dip	V	-20.6	Pk	18.6	21.5	71.7	75.6	3.9	end
4	630.0	Dip	Н	-63.0	Pk	24.4	18.4	38.2	55.6	17.4	flat
5	630.0	Dip	V	-63.5	Pk	24.4	18.4	37.7	55.6	17.9	end
6	945.0	Dip	Н	-64.3	Pk	28.8	16.4	43.3	55.6	12.3	flat
7	945.0	Dip	V	-75.5	Pk	28.8	16.4	32.1	55.6	23.5	end
8	1260.0	Horn	Н	-60.6	Pk	20.6	28.1	27.1	54.0	26.9	side
9	1575.0	Horn	Н	-64.0	Pk	21.5	28.1	24.6	54.0	29.4	end
10	1890.0	Horn	Н	-60.3	Pk	22.2	28.1	29.0	55.6	26.6	side
11	2205.0	Horn	Н	-58.0	Pk	23.0	26.5	33.7	54.0	20.3	side
12	2520.0	Horn	Н	-57.2	Pk	23.9	26.0	35.9	55.6	19.8	side
13	2835.0	Horn	Н	-54.3	Pk	24.8	24.7	41.0	54.0		flat
14	3150.0	Horn	Н	-45.7	Pk	25.8	23.6	51.7	55.6	3.9	side
15											
	DUT2 (R									1	T
17	315.0	Dip	Н	-18.7	Pk	18.6	21.5	73.6	75.6		flat
18	315.0	Dip	V	-21.4	Pk	18.6	21.5	70.9	75.6		end
19	630.0	Dip	Н	-69.6	Pk	24.4	18.4	31.6	55.6		flat
20	630.0	Dip	V	-70.1	Pk	24.4	18.4	31.1	55.6	24.5	end
21	945.0	Dip	Н	-66.4	Pk	28.8	16.4	41.2	55.6		flat
22	945.0	Dip	V	-77.6	Pk	28.8	16.4	30.0	55.6		flat
23	1260.0	Horn	Н	-61.4	Pk	20.6	28.1	26.3	54.0	27.7	end
24	1575.0	Horn	Н	-63.2	Pk	21.5	28.1	25.4	54.0		flat
25	1890.0	Horn	Н	-59.0	Pk	22.2	28.1	30.3	55.6	25.3	side
26	2205.0	Horn	Н	-63.0	Pk	23.0	26.5	28.7	54.0	25.3	side
27	2520.0	Horn	Н	-60.4	Pk	23.9	26.0	32.7	55.6	23.0	side
28	2835.0	Horn	Н	-51.0	Pk	24.8	24.7	44.3	54.0	9.7	side
29	3150.0	Horn	Н	-43.4	Pk	25.8	23.6	54.0	55.6	1.6	side
30	D. T. T. T. T.										
	DUT3 (L										[ <sub>a</sub>
32	315.0	Dip	Н	-17.2	Pk	18.6	21.5	75.1	75.6	0.5	flat
33											
	`					r	21.5	<b>5</b> 0 1			l <sub>a</sub>
35	315.0	Dip	Н	-18.9	Pk	18.6	21.5	73.4	75.6	2.2	flat
36											
37				D: : :			.1	ID : :	FGG 7.2 2:	D	<u> </u>
38				Digital	emissio	ns more	than 20	dB below	FCC/IC Clas	s B Liı	nıt. I
39											

Meas. 02/11/2009; U of Mich.

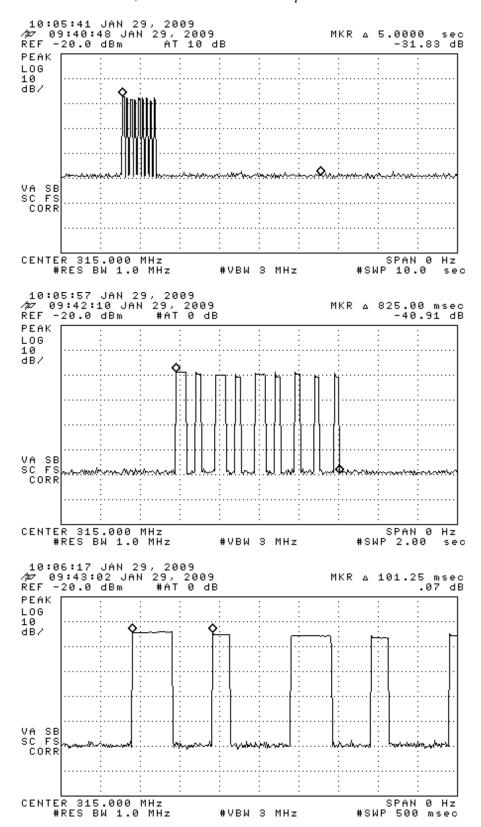


Figure 6.1(a). Button Press Transmission modulation. (top) Single press response, (center) expanded transmission (a fast press would show only three repeated groups (6 words)), (bottom) word period (shows ASK word, FSK word, FSK word, FSK word,...).

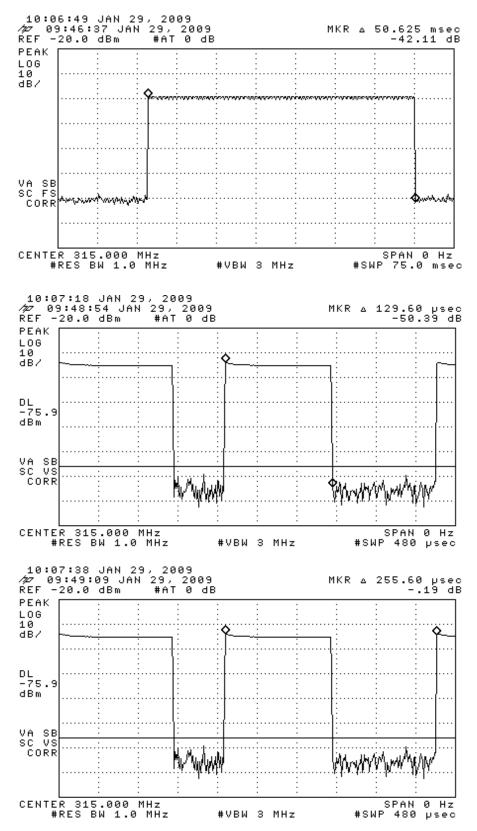


Figure 6.1(b). Button Press. ASK Transmission. (top) ASK Manchester word, (center) ASK pulse width, (bottom) ASK pulse period.

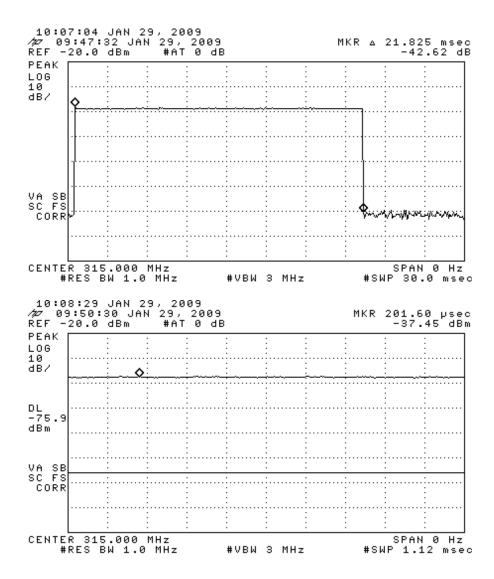


Figure 6.1(c). Button Press. FSK Transmission. (top) FSK pulse width, (bottom) FSK pulse is continuous.

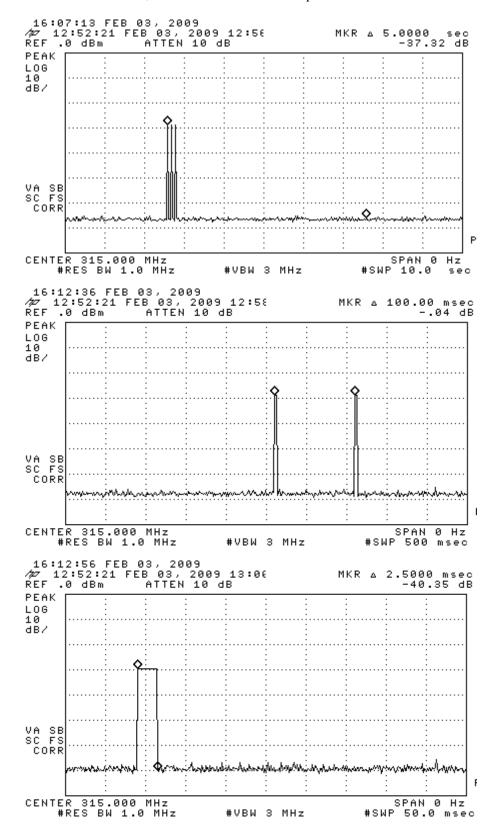


Figure 6.1(d). LF Inter. Transmission modulation. (top) Single button press transmission, (center) expanded transmission (a fast button press would show only a single pulse), (bottom) expanded word.

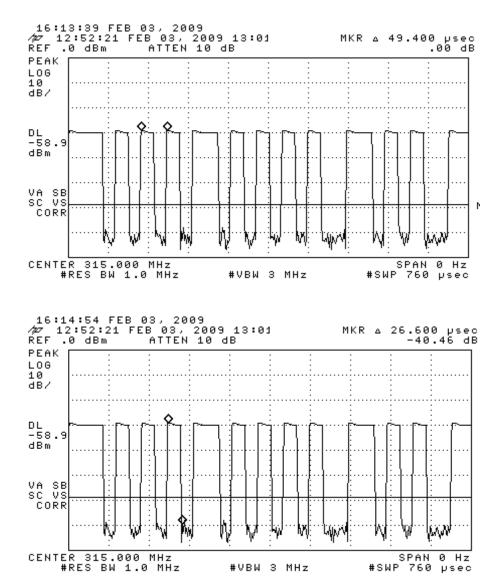


Figure 6.1(e). LF Inter. Transmission modulation. (top) Manchester period, (bottom) Manchester pulse width.

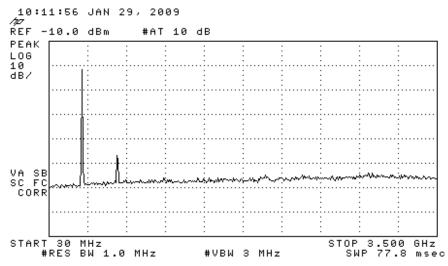


Figure 6.2. Emission spectrum of the DUT (pulsed emission). Amplitudes are only indicative (not calibrated).

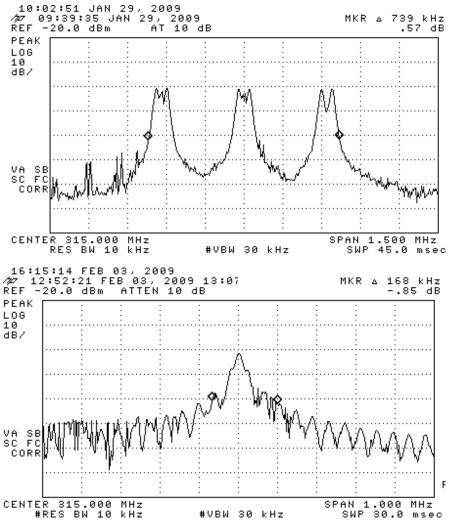


Figure 6.3. Measured emission bandwidth of the DUT (pulsed). (top) Button Press (ASK+FSK+3 freq.), (bottom) LF interrogation response (ASK only at 315.0 MHz)

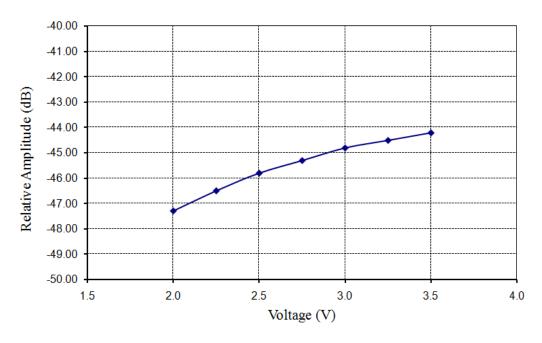


Figure 6.4. Relative emission at fundamental vs. supply voltage (pulsed).



Photograph 6.5. DUT on OATS (one of three axes tested)



Photograph 6.6. Close-up of DUT on OATS with drawers closed (one of three axes tested)



Photograph 6.7. Close-up of DUT on OATS with drawers open (one of three axes tested)